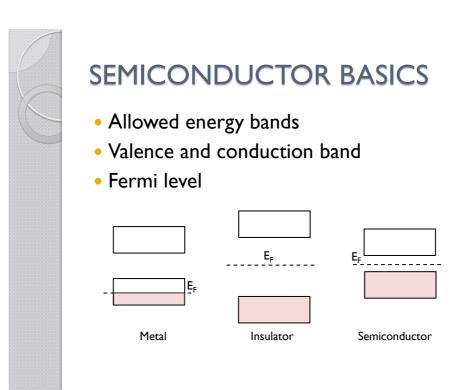
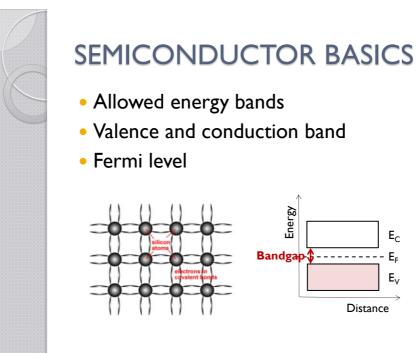


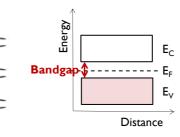


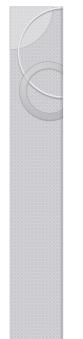
### **PV FUNDAMENTALS**

- Semiconductor basics
- pn junction
- Solar cell operation
- Design of silicon solar cell

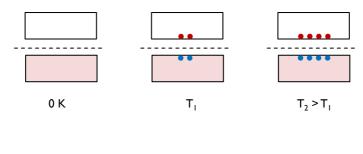


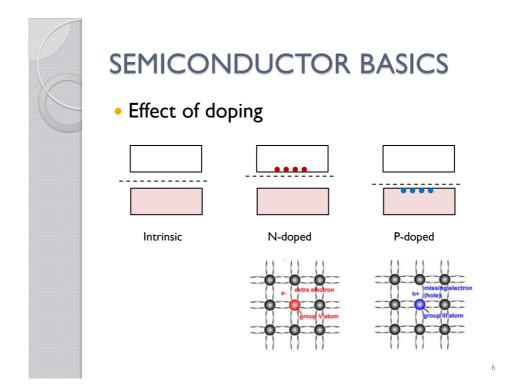






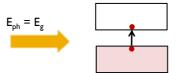
### • Effect of temperature

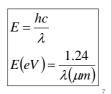






• **Absorption of light** depends on the energy of the photon (wavelength)

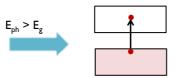


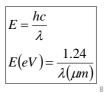




### SEMICONDUCTOR BASICS

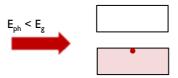
• **Absorption of light** depends on the energy of the photon (wavelength)

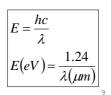


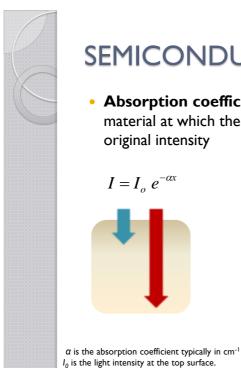




• Absorption of light depends on the energy of the photon (wavelength)





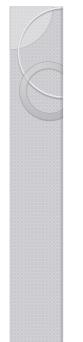


### SEMICONDUCTOR BASICS

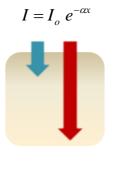
• Absorption coefficient [cm<sup>-1</sup>]: the distance into the material at which the light drops to about 1/e of its original intensity

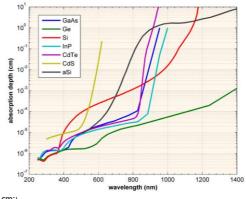
$$I = I_o e^{-\alpha x}$$

 $E = \frac{hc}{\lambda}$  $E(eV) = \frac{1.24}{\lambda(\mu m)}$ 



• Absorption coefficient [cm<sup>-1</sup>]: the distance into the material at which the light drops to about I/e of its original intensity



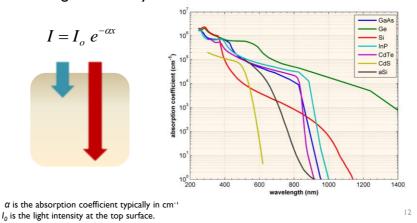


П

 $\alpha$  is the absorption coefficient typically in cm  $^{-1}$   $l_0$  is the light intensity at the top surface.



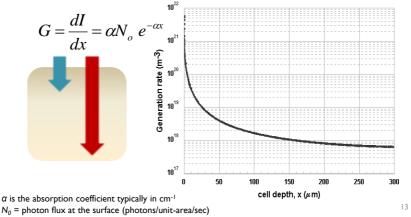
• Absorption coefficient [cm<sup>-1</sup>]: the distance into the material at which the light drops to about 1/e of its original intensity





### **PV FUNDAMENTALS**

• The **generation rate** gives the number of electrons generated at each point in the device due to the absorption of photons.

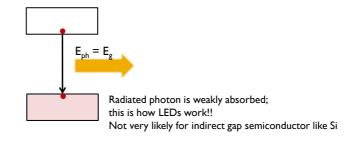




### **PV FUNDAMENTALS**

#### Recombination may occur through...

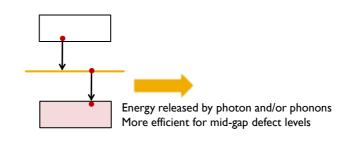
• Radiative recombination - an electron directly combines with a hole in the conduction band and releases a photon

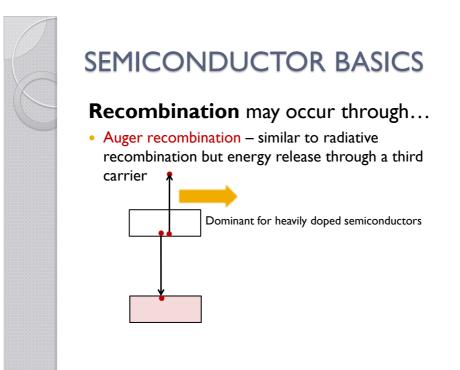




#### Recombination may occur through...

• Shockley-Read-Hall recombination – 2-step process: an electron is trapped in a defect level





16



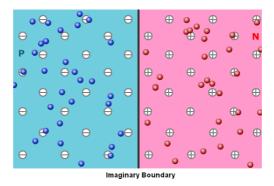
Recombination is characterized by...

- Recombination rate
- Minority carrier lifetime how long a carrier is likely to stay around for before recombining
- Diffusion length average distance a carrier can move from point of generation until it recombines

$$\tau = \frac{\Delta n}{R} \quad L = \sqrt{D\tau}$$



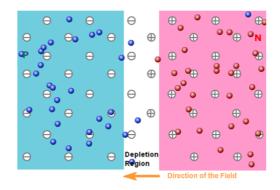
# PN JUNCTION



18



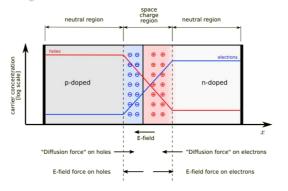
# PN JUNCTION

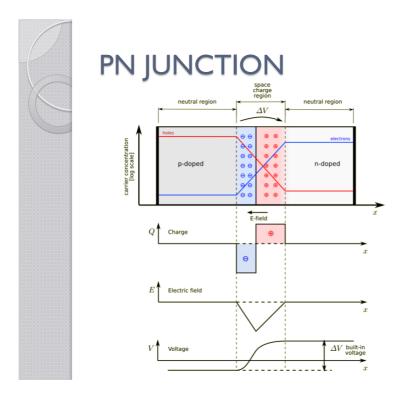






# PN JUNCTION



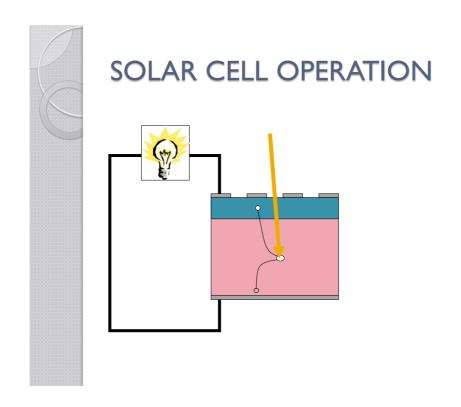


#### **Basic steps:**

• the generation of light-generated carriers;

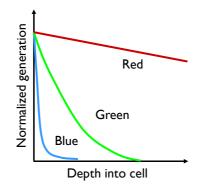
21

- the collection of the light-generated carries to generate a current;
- the generation of a voltage across the solar cell; and
- the dissipation of power in the load and in parasitic resistances.



### **Basic steps:**

• the generation of light-generated carriers

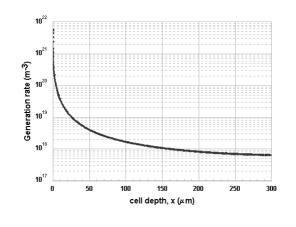


24

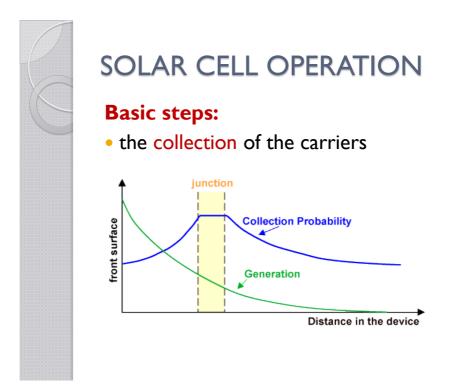


#### **Basic steps:**

• the generation of light-generated carriers



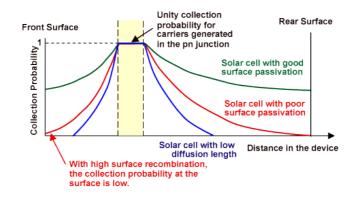






#### **Basic steps:**

• the collection of the carriers



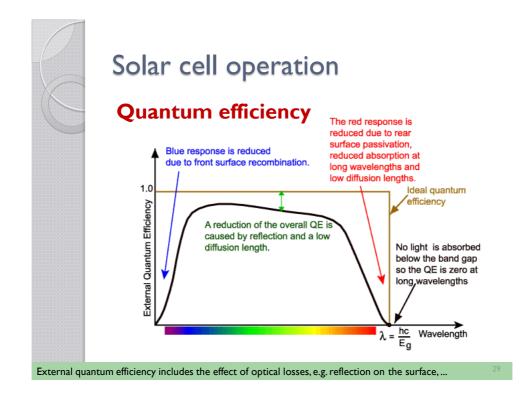




### Solar cell operation

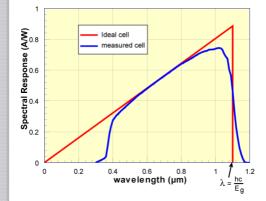
#### **Quantum efficiency**

Ratio of the number of carriers collected to the number of photons of a given energy incident



#### **Spectral response**

Ratio of the **current** generated by the solar cell to the **power** incident on the solar cell



Spectral Response (SR) is measured

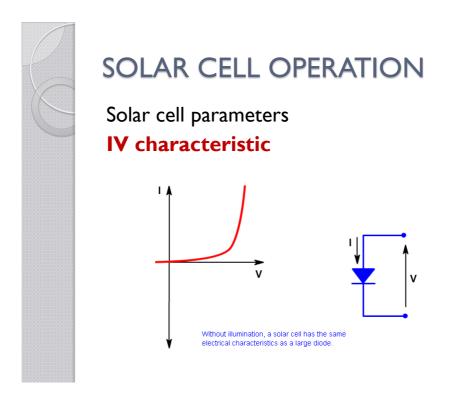
Quantum Efficiency (QE) is calculated from SR:

$$SR = \frac{q\lambda}{hc}QE$$



Solar cell parameters IV characteristic

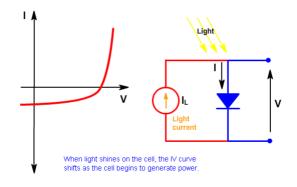
= diode + light generated current



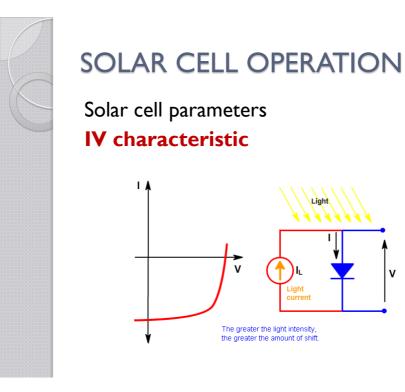
31



Solar cell parameters IV characteristic

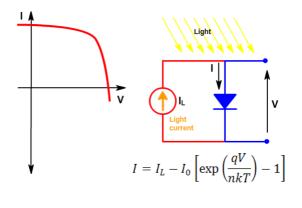


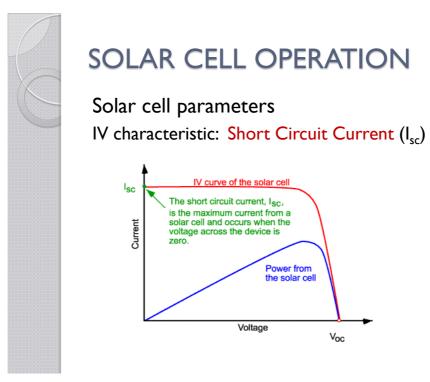






Solar cell parameters IV characteristic





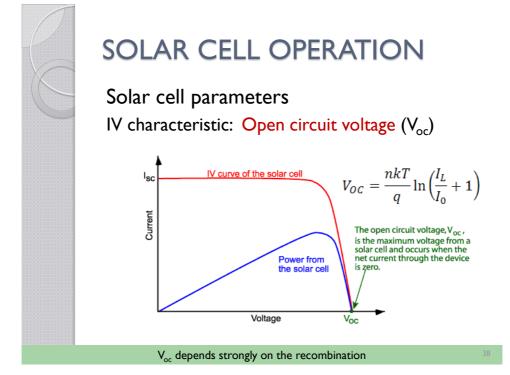
36

#### Solar cell parameters

#### IV characteristic: Short Circuit Current (I<sub>sc</sub>)

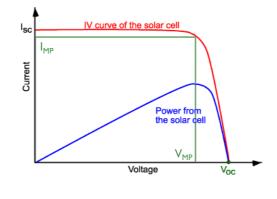
- Area of the solar cell (common to use  $J_{sc}$  in mA/cm<sup>2</sup>)
- Incident flux (i.e. number of photons)
- Spectrum incident light
- Optical properties of the solar cell
- Collection probability, e.g. diffusion length

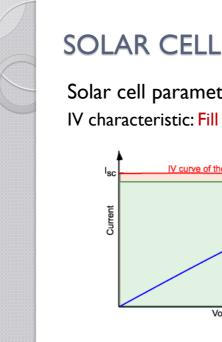
$$J_{SC} = qG(L_n + L_p)$$



Solar cell parameters

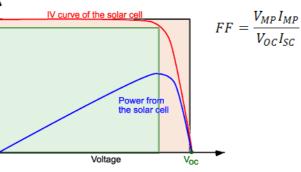
IV characteristic: Maximum power





SOLAR CELL OPERATION

Solar cell parameters IV characteristic: Fill factor (FF)



40



Solar cell parameters

**Efficiency**  $(\eta)$  is the fraction of incident power which is converted to electricity

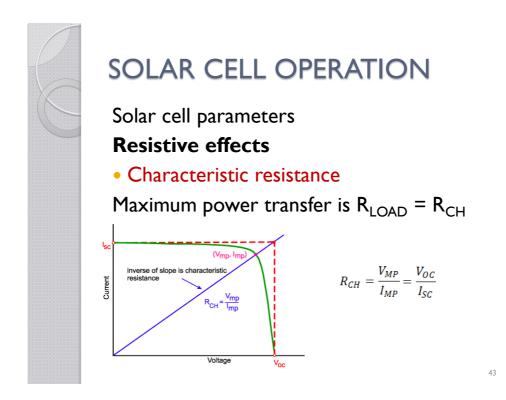
 $P_{max} = V_{OC}I_{SC}FF \qquad \qquad \eta = \frac{V_{OC}I_{SC}FF}{P_{in}}$ 

### SOLAR CELL OPERATION

Solar cell parameters

#### **Resistive effects**

- Characteristic resistance
- Parasitic resistance

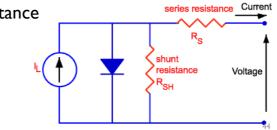




Solar cell parameters

#### **Resistive effects**

- Characteristic resistance
- Parasitic resistance
  - Series resistance
  - Shunt resistance



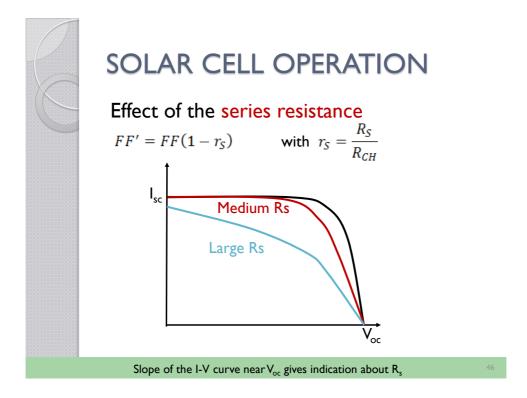


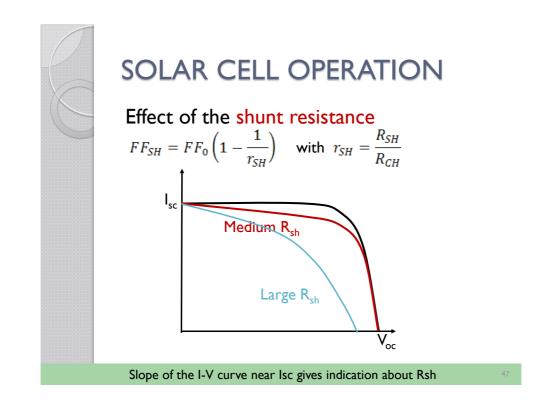
Solar cell parameters

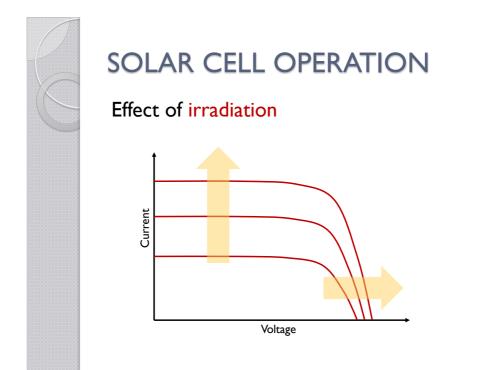
#### **Resistive effects**

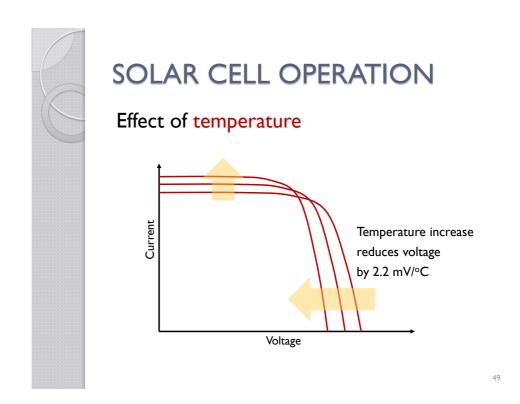
- Characteristic resistance
- Parasitic resistance
  - Series resistance
  - Shunt resistance

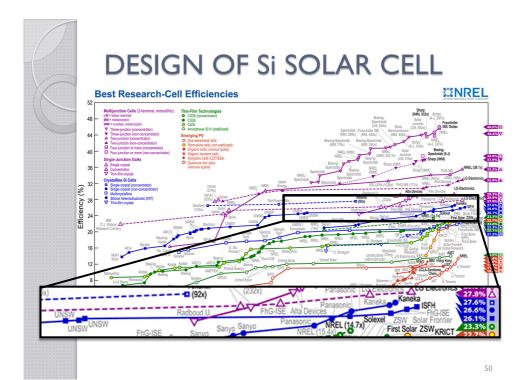
$$I = I_L - I_0 \exp\left[\frac{q(V - IR_S)}{nkT}\right] - \frac{V + IR_S}{R_{SH}}$$





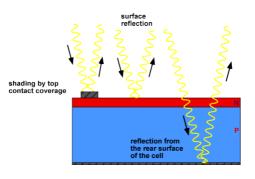








**Optical losses** - light which could have generated an electron-hole pair, but does not, because the light is reflected from the front surface, or because it is not absorbed in the solar cell.



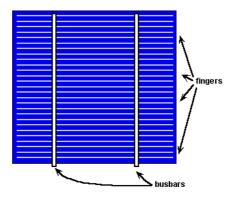


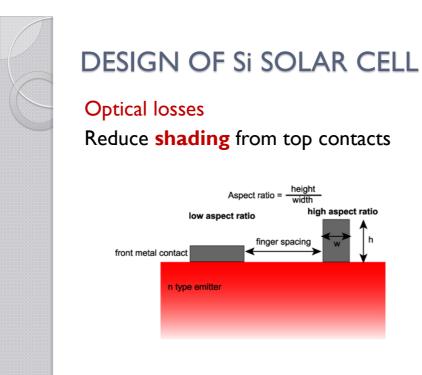
### **DESIGN OF Si SOLAR CELL**

- **Optical losses** light which could have generated an electron-hole pair, but does not, because the light is reflected from the front surface, or because it is not absorbed in the solar cell.
- Top contact shading
- Top surface reflection
- Not enought optical path for photon absorption



Optical losses Reduce **shading** from top contacts



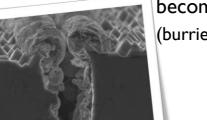


54

#### **Optical losses**

Reduce shading from top contacts

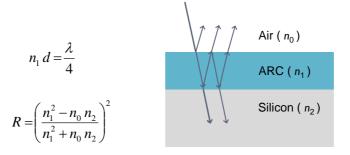
- May increase series resistance
- Other emitter contact concepts



becoming fashionable (burried or back contacts)

# DESIGN OF Si SOLAR CELL

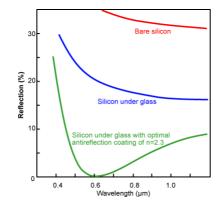
Optical losses Anti-reflective coating

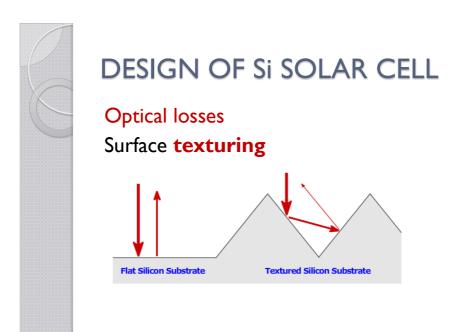




**Optical losses** 

Anti-reflective coating





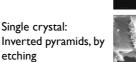
58



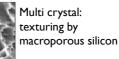
### Optical losses Surface **texturing**



Single crystal: Random pyramids, by etching



Multi crystal: texturing by photolithography



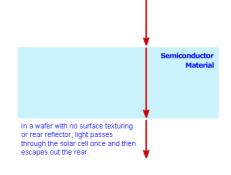
59

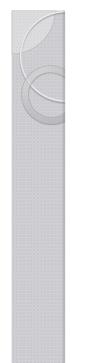
C

### DESIGN OF Si SOLAR CELL

Optical losses

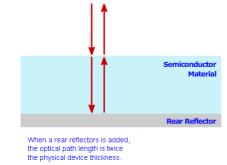
Light trapping: increase optical length

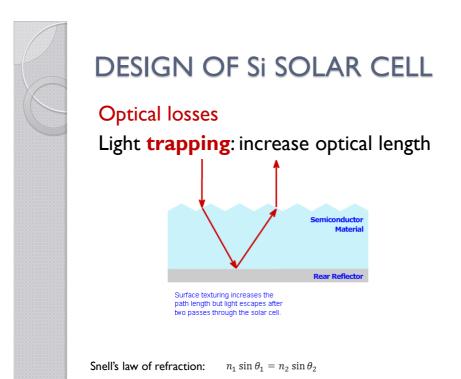




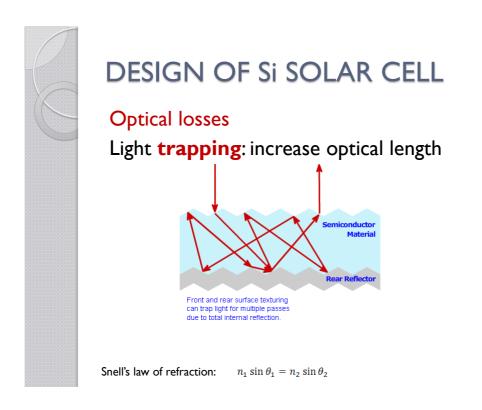
**Optical losses** 

Light trapping: increase optical length





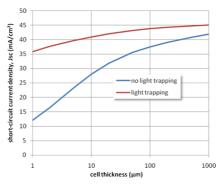
62





#### **Optical losses**

Light trapping: increase optical length



Snell's law of refraction:

 $n_1\sin\theta_1=n_2\sin\theta_2$ 



#### **Optical losses**

In summary:

- Reduce front contact coverage
- Anti-reflective coating
- Surface texturing
- Light trapping

## DESIGN OF Si SOLAR CELL

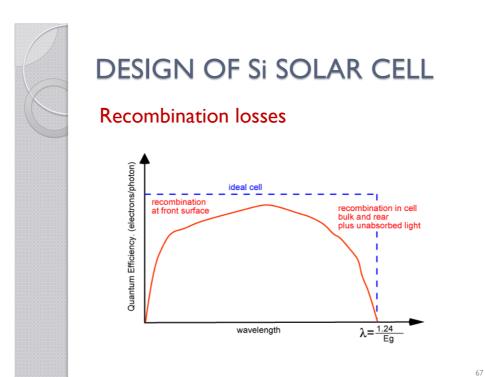
65

66

#### **Recombination losses**

**Optimal conditions:** 

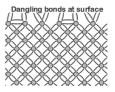
- the carrier must be generated within a diffusion length of the junction;
- the carrier must be generated closer to the junction than to *hazardous* recombination sites (unpassivated surface, grain boundary,...)





#### Recombination losses: Surface **passivation**

 Reducing the number of dangling bonds by growing a SiO<sub>2</sub> or SiN thin film on the surface (also for anti-reflection coating; notice that it is an electric insulator)

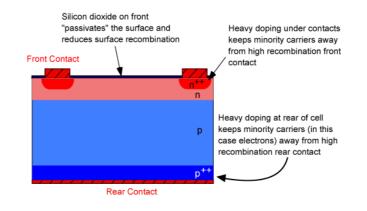


Increasing doping, creating a repelling field

(decreases diffusion length thus not suitable for charge collection region; useful closer to contacts, e.g. Back Surface Field - BSF)



#### Recombination losses: Surface **passivation**



69



### **DESIGN OF Si SOLAR CELL**

TABLE 1 Confirmed single-junction terrestrial cell and submodule efficiencies measured under the global AM1.5 spectrum (1000 W/m<sup>2</sup>) at 25°C (IEC 60904-3: 2008, ASTM G-173-03 global). New entries in bold type

	Efficiency	Area	Voc	J <sub>sc</sub>	Fill Factor	Test Centre	
Classification	(%)	(cm <sup>2</sup> )	(V)	(mA/cm <sup>2</sup> )	(%)	(date)	Description
Silicon							
Si (crystalline cell)	26.7 ± 0.5	79.0 (da)	0.738	42.65 <sup>a</sup>	84.9	AIST (3/17)	Kaneka, n-type rear IBC <sup>5</sup>
Si (multicrystalline cell)	$21.9 \pm 0.4^{b}$	4.0003 (t)	0.6726	40.76 <sup>a</sup>	79.7	FhG-ISE (2/17)	FhG-ISE, n-type <sup>6</sup>
Si (thin transfer submodule)	21.2 ± 0.4	239.7 (ap)	0.687 <sup>c</sup>	38.50 <sup>c,d</sup>	80.3	NREL (4/14)	Solexel (35 µm thick) <sup>7</sup>
Si (thin film minimodule)	10.5 ± 0.3	94.0 (ap)	0.492 <sup>c</sup>	29.7 <sup>c</sup>	72.1	FhG-ISE (8/07) <sup>e</sup>	CSG Solar (<2 µm on glass) <sup>8</sup>

 TABLE 4
 "Notable exceptions": "Top dozen" confirmed cell and module results, not class records measured under the global AM1.5 spectrum (1000 Wm<sup>-2</sup>) at 25°C (IEC 60904-3: 2008, ASTM G-173-03 global). New entries in bold type

Efficiency		Area	Voc	J <sub>sc</sub>	Fill Factor	Test Centre		
Classification	(%)	(cm <sup>2</sup> )	(V)	(mA/cm <sup>2</sup> )	(%)	(date)		
Cells (silicon)								
Si (crystalline)	25.0 ± 0.5	4.00 (da)	0.706	42.7 <sup>a</sup>	82.8	Sandia (3/99) <sup>b</sup>	UNSW p-type PERC top/rear contacts40	
Si (crystalline)	$25.7 \pm 0.5^{\circ}$	4.017 (da)	0.7249	42.54 <sup>d</sup>	83.3	FhG-ISE (3/17)	FhG-ISE, n-type top/rear contacts <sup>41</sup>	
Si (large)	26.6 ± 0.5	179.74 (da)	0.7403	42.5 <sup>d</sup>	84.7	FhG-ISE (11/16)	Kaneka, n-type rear IBC <sup>5</sup>	
Si (multicrystalline)	21.3 ± 0.4	242.74 (t)	0.6678	39.80°	80.0	FhG-ISE (11/15)	Trina Solar, large p-type <sup>42</sup>	



(ap), aperture area; (t), total area; (da), designated illumination area



**TABLE 1**Confirmed single-junction terrestrial cell and submodule efficiencies measured under the global AM1.5 spectrum (1000 W/m<sup>2</sup>) at 25°C(IEC 60904-3: 2008, ASTM G-173-03 global). New entries in bold type

	Efficiency	Area	Voc	J <sub>sc</sub>	Fill Factor	Test Centre	
Classification	(%)	(cm <sup>2</sup> )	(V)	(mA/cm <sup>2</sup> )	(%)	(date)	 Description
Silicon							
Si (crystalline cell)	26.7 ± 0.5	79.0 (da)	0.738	42.65 <sup>a</sup>	84.9	AIST (3/17)	Kaneka, n-type rear IBC <sup>5</sup>
Si (multicrystalline cell)	$21.9 \pm 0.4^{b}$	4.0003 (t)	0.6726	40.76 <sup>a</sup>	79.7	FhG-ISE (2/17)	FhG-ISE, n-type <sup>6</sup>
Si (thin transfer submodule)	21.2 ± 0.4	239.7 (ap)	0.687 <sup>c</sup>	38.50 <sup>c,d</sup>	80.3	NREL (4/14)	Solexel (35 µm thick) <sup>7</sup>
Si (thin film minimodule)	10.5 ± 0.3	94.0 (ap)	0.492 <sup>c</sup>	29.7 <sup>c</sup>	72.1	FhG-ISE (8/07)e	CSG Solar (<2 µm on glass)

TABLE 3 Confirmed terrestrial module efficiencies measured under the global AM1.5 spectrum (1000 W/m<sup>2</sup>) at a cell temperature of 25°C (IEC 60904-3: 2008, ASTM G-173-03 global). New entries in bold type

	Area	V <sub>oc</sub>	sc	FF	Test Centre	
(%)	(cm <sup>2</sup> )	(V)	(A)	(%)	(date)	Description
24.4 ± 0.5	13177 (da)	79.5	5.04 <sup>a</sup>	80.1	AIST (9/16)	Kaneka (108 cells) <sup>5</sup>
19.9 ± 0.4	15143 (ap)	78.87	4.795 <sup>a</sup>	79.5	FhG-ISE (10/16)	Trina Solar (120 cells) <sup>33</sup>
	24.4 ± 0.5	24.4 ± 0.5 13177 (da)	24.4 ± 0.5 13177 (da) 79.5	24.4 ± 0.5 13177 (da) 79.5 5.04 <sup>a</sup>	24.4 ± 0.5 13177 (da) 79.5 5.04 <sup>a</sup> 80.1	24.4 ± 0.5 13177 (da) 79.5 5.04 <sup>a</sup> 80.1 AIST (9/16)

Solar cell efficiency tables (version 50) Martin A. Green et al

71



### Next class...

- How to make a practical photovoltaic module
- Other (non-silicon) technologies

A new set of exercises. And check <u>http://pvcdrom.pveducation.org/</u>